

Part: HL-304IR3C-L3



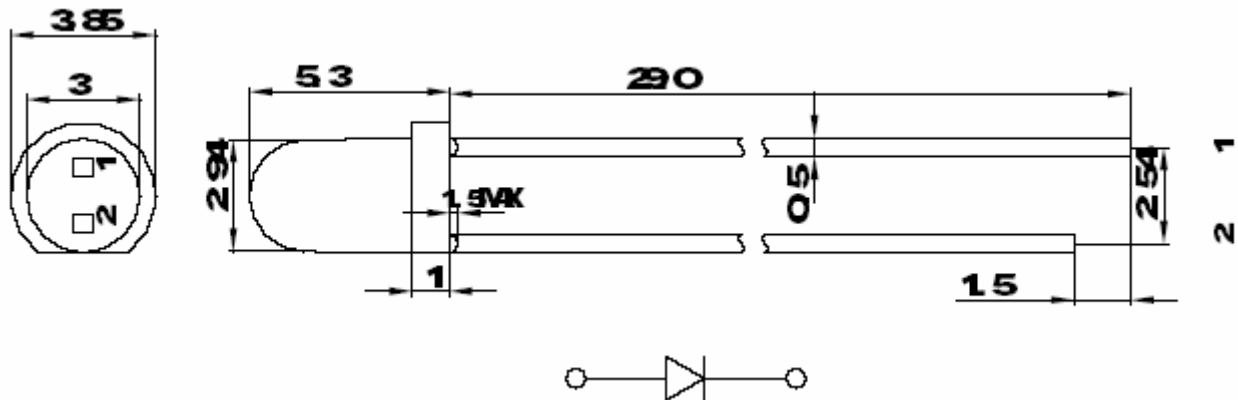
Features:

- Mechanically and spectrally matchend to the phototransistor.
- Rohs compliant.

Description:

This devices are made with PIN GaAs.

Package Dimensions:



Tolerance Grade	Dimension Tolerance (UNIT:mm)			
	0.5~3	3~6	6~30	30~120
Medium (m)	±0.1	±0.2	±0.3	±0.5
Chip		Lens Color		
Material	Emitting Color	Water Clear		
GaAs	/			

■ Selection Guide

Part NO	Radiant Intensity (mW/sr) If=50mA		Viewing Angle
	Min	Typ	2θ 1/2
HL-304IR3C-L3	--	26	40

Note:

1. 2θ1/2 is the angle from optical centerline where the luminous intensity is 1/2 the optical centerline value.

2. Tolerance of measurement of luminous intensity ±15%.

■ Typical Optical/ Electrical Characteristics

Item	Symbol	Test Condition	Min.	Typ.	Unit
Forward Voltage	VF	IF=50mA	--	1.5	V
Reverse Current	IR		--	10	uA
Prpc Wavelength	λD		--	940	nm
Spectral Bandwidth	Δλ 1/2		--	50	nm

Notes:

1. Absolute maximum ratings Ta=25°C.

2. Tolerance of measurement of forward voltage ±0.1V.

3. Tolerance of measurement of peak Wavelength ±2.0nm.

■ Absolute Maximum ratings at Ta=25°C

Parameter	Symbol	IR1	Units
Power Dissipation	Pt	100	mW
DC Forward Current	IF	50	mA
Peak Forward Current [1]	IFS	300	mA
Operation Temperature		-30~+80 °C	
Storage Temperature		-30~+80 °C	

Note:

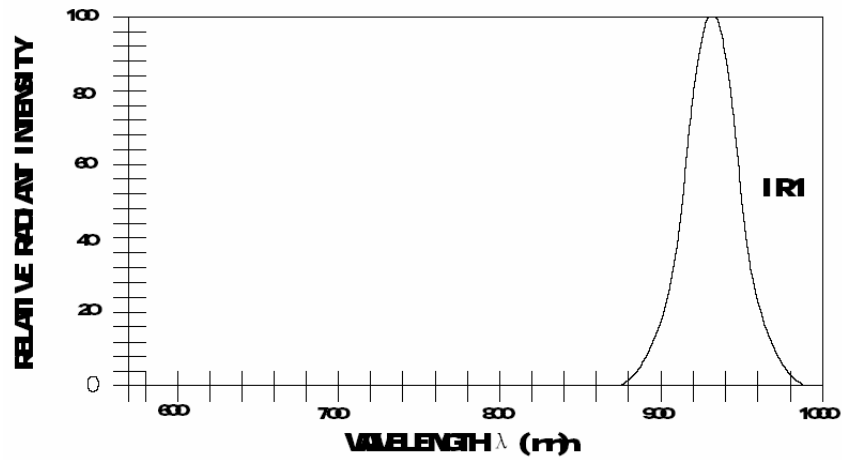
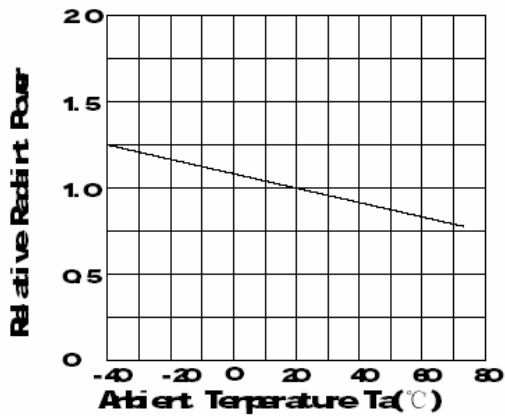
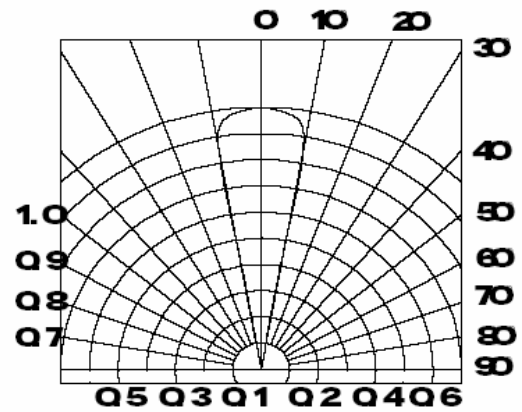
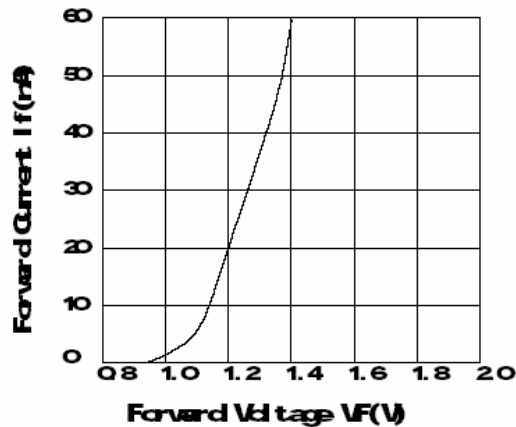
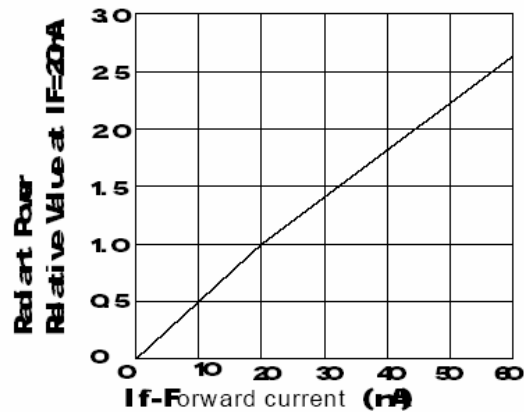
1. IFP Conditions: Pulse Width ≤ 10msec

2. Tsol Conditions: 3mm from the base of the epoxy bulb

■ Reliability Performance Test Items And Result

Test Classification	Test Item	Test Conditions	Test Duration	Sample Size	AC/RE
Life Test	Room Temperature DC Operating Life Test	Ta=25°C ±5°C, IF=20mA	1000 hrs	22 pcs	0/1
Environment Test	Thermal Shock Test	100°C ±5°C 5min ↑↓ -40°C ±5°C 5min.	100 cycles	22 pcs	0/1
	Temperature Cycle Test	100°C ±5°C 30min ↑↓5min -40°C ±5°C 30min.	100 cycles	22 pcs	0/1
	Temperature & Cycle Test	85°C ±5°C /85% RH IF=5mA	1000 hrs	22 pcs	0/1
	Temperature Cycle Test	Ta=100°C ±5°C	1000 hrs	22 pcs	0/1
	Low Temperature Storage	Ta=100°C ±5°C	1000 hrs	22 pcs	0/1
Mechanical Test	Resistance to Soldering Heat	Ta=100°C ±5°C	1 times	22 pcs	0/1

	Lead Integrity	Load 2.5N(0.25kgf) 0° ~ 90° ~ 0°	3times	22 pcs	0/1
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Forward Current vs. Forward Voltage

Radiant Power Vs. Ambient Temperature

Spatial Distribution

Forward Current vs. Forward Voltage

Radiant Power vs Forward Current

Remarks:

If special sorting is required (e.g. binning based on forward voltage or radiant intensity/luminous flux), the typical accuracy of the sorting process is as follows:

1. Radiant intensity/Luminous Flux: $\pm 15\%$.
2. Forward Voltage: $\pm 0.1V$.

Note: Accuracy may depend on the sorting parameters.

Soldering:

1. Manual Of Soldering

The temperature of the iron tip should not be higher than 260°C (500°F) and Soldering within 3 seconds per solder-land is to be observed.

2. DIP soldering (Wave Soldering):

Preheating: 120°C ~150°C, within 120~180 sec.

Operation heating: 245°C ±5°C within 5 sec. 260°C (Max)

Gradual Cooling (Avoid quenching).

